

QUERY CONTROL FORM		RTIS USE ONLY	
Application No. <u>09/865,197</u>	Prepared by <u>BSH</u>	Tracking Number <u>05938755</u>	
Examiner-GAU <u>Kim-2871</u>	Date <u>05-20-04</u>	Week Date <u>04-19-2004</u>	
	No. of queries <u>1</u>	<u>IFN-RU8</u>	

JACKET

a. Serial No.	f. Foreign Priority	k. Print Claim(s)	p. PTO-1449
b. Applicant(s)	g. Disclaimer	l. Print Fig.	q. PTOL-85b
c. Continuing Data	h. Microfiche Appendix	m. Searched Column	r. Abstract
d. PCT	i. Title	n. PTO-270/328	s. Sheets/Figs
e. Domestic Priority	j. Claims Allowed	o. PTO-892	t. Other

SPECIFICATION

- a. Page Missing
- b. Text Continuity
- c. Holes through Data
- d. Other Missing Text
- e. Illegible Text
- f. Duplicate Text
- g. Brief Description
- h. Sequence Listing
- i. Appendix
- j. Amendments
- k. Other

CLAIMS

- a. Claim(s) Missing
- b. Improper Dependency
- c. Duplicate Numbers
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MESSAGE

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RESPONSE

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**PATENT AND TRADEMARK OFFICE
INFORMATION DISCLOSURE CITATION**

(Use several sheets if necessary)

Sheet 1 of 2

ATTORNEY DOCKET NO.

9319S-000214

SERIAL NO.

09/865,197

APPLICANT

Hanakawa, et al.

FILING DATE

May 24, 2001

GROUP

2871

U.S. PATENT DOCUMENTS

Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
1.		2001/0026120	Oct/2001	Fukuyoshi, et al.		

FOREIGN PATENT DOCUMENTS

R 1. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation * Yes No	
1.		11-282383	Oct/1999	Japan		Abstract	
2.		EP 0 733 931 A3	Aug/1997	Europe			
3.		EP 0 733 931 A2	Sep/1996	Europe			

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)

Ref. Desig.	Examiner's Initials	
1.		Communication from European Patent Office regarding counterpart application
2.		Patent Abstracts of Japan for JP 2000-180848
3.		Patent Abstracts of Japan for JP 2000-019507
4.		Patent Abstracts of Japan for JP 11-224647
5.		Patent Abstracts of Japan for JP 08-262207
6.		Patent Abstracts of Japan for JP 08-146219

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